

<b>Notice of References Cited</b>	Application/Control No. 10/509,630	Applicant(s)/Patent Under Reexamination UMEDA, AKIRA	
	Examiner Charles D. Garber	Art Unit 2856	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	PTO 06-349 English language translation of Umeda, Japanese Kokai Patent Application No. Hei 1[1992]-93653
	V	PTO 06-3084 English language translation of Umeda et al., "Frequency Characteristics of Accelerometers Measured by Impact in Low Frequencies",
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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